

# Monolithic Accelerometer with Signal Conditioning

## ADXL181\*

#### FEATURES

Complete Acceleration Measurement System on a Single Monolithic IC Full-Scale Measurement Range: +5 V Supply: -125 g, +250 g +12 V Supply: -150 g, +880 g Self-Test on Digital Command Single Supply Operation Sensitivity Precalibrated to 8 mV/g Internal Buffer Amplifier for User Adjustable Sensitivity and Zero-g Level Frequency Response: DC to 3 kHz Post Filtering with External Passive Components High Shock Survival: >2000 g Unpowered Other Products Available Providing Different Sensitivities and Full-Scale Ranges

#### **GENERAL DESCRIPTION**

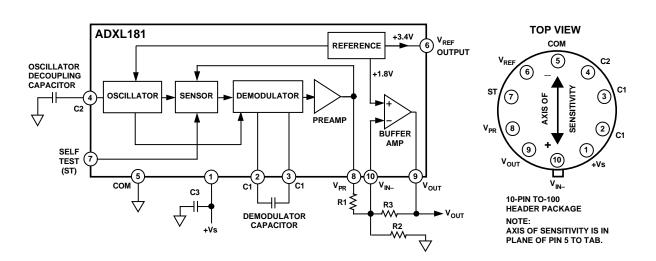
The ADXL181 is a complete acceleration measurement system on a single monolithic IC, using a surface micromachined capacitive measurement method. The analog output voltage is directly proportional to acceleration and is fully scaled, referenced, and temperature compensated, resulting in high accuracy and linearity over a wide temperature range. Internal circuitry implements a force-balance control loop that compensates for any mechanical sensor variations.

A TTL compatible self-test feature can electrostatically deflect the sensor beam at any time to verify device functionality.

An internal buffer amplifier has a 0.25 V to  $V_{\rm S}$  – 0.25 V output range. This may be used to gain and offset adjust the output signal so that it has a symmetrical output range. The amplifier can also be used to gain adjust and filter the sensor output. No external active components are necessary to connect the output signal directly to an analog-to-digital converter or microcontroller.

The ADXL181 is packaged in a hermetic 10-pin TO-100 metal can. Contact factory for availability of devices with specific temperature ranges and performance.

#### FUNCTIONAL BLOCK DIAGRAM AND PINOUT



#### \*Patent pending.

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# $\label{eq:ADXL181-SPECIFICATIONS} \begin{array}{l} (T_{A}=+25^{\circ}\text{C}, \ V_{S}=+5 \ \text{V}, \ @ \ \text{Acceleration}=0 \ \text{g}, \ \text{and} \ \text{C1}=\text{C2}=0.022 \ \mu\text{F} \\ \text{unless otherwise noted} \end{array}$

Parameter	r Min Typ Max		Units		
SENSITIVITY +25°C Temperature Drift		8 ±0.75		mV/g % of Reading	
ZERO g BIAS LEVEL +25°C T <sub>MIN</sub> -T <sub>MAX</sub> Temperature Drift		8 ±75		V V mV	
VOLTAGE NOISE DENSITY		65	65		
SENSOR INPUT FS Measurement Range <sup>1</sup> Nonlinearity Alignment Error Transverse Sensitivity	-125	$0.2 \\ \pm 1 \\ \pm 2$	+250	g % of FS Degrees %	

NOTES

<sup>1</sup>Accelerations up to -150 g, +880 g using a +12 V Supply.

Specifications subject to change without notice.

-F	$(T - T + t_0 T) = (T - T) + 5\%$ @ Accoloration = 0 g and $(T - C) = 0.022$
	(T <sub>A</sub> = T <sub>MIN</sub> to T <sub>MAX</sub> , V <sub>S</sub> = +5 V $\pm$ 5% @ Acceleration = 0 g, and C1 = C2 = 0.022 $\mu F$ unless otherwise noted)
FIFUIRICAL CHARACTERISTICS	unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Units
PREAMPLIFIER OUTPUT Power Supply Rejection Voltage Swing Current Output Capacitive Load Drive	DC +25°C Source or Sink	30 0.25 30	40 80 100	V <sub>S</sub> - 0.25	dB V μA pF
SELF-TEST INPUT Output Change at V <sub>PR</sub> ST Pin from Logic "0" to "1" Logic "1" Voltage Logic "0" Voltage Input Impedance	To Common	-0.80 2.0	-0.90 50	-1.00 0.8	V V V kΩ
FREQUENCY RESPONSE 3 dB Equation C1> = 0.015 μF Bandwidth Sensor Resonant Frequency			3000 10,000 24		Hz Hz kHz
+3.4 VOLT REFERENCE Output Voltage Initial Output Temperature Drift Power Supply Rejection Output Current	+25°C DC (Sourcing)	3.350 40 500	$3.400 \pm 10 60$	3.450	V mV dB µA
BUFFER AMPLIFIER Input Offset Voltage Input Bias Current Open Loop Gain Unity Gain Bandwidth Output Voltage Swing Capacitive Load Drive	Deviation from Nominal 1.800 V DC I <sub>OUT</sub> = 100 μA	0.25 1000	$\pm 10 \\ 5 \\ 80 \\ 200$	±25 20 V <sub>S</sub> - 0.25	mV nA dB kHz V pF
POWER SUPPLY Specified Performance Quiescent Supply Current	5 V Supply 12 V Supply 5 V Supply	+4.75 +11.6	11	$+5.25 +12.6 \\ 14$	V V mA
TEMPERATURE RANGE		-55		+125	°C

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